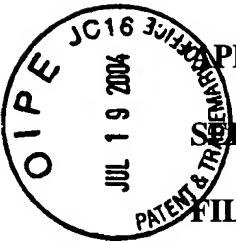


*Jae*  
Analog.7061 2838

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE



APPLICANT: Eamon Nash GROUP: 2838  
SERIAL NO: 10/774,905 EXAMINER: Unknown  
FILED: 02/09/2004

FOR: SYSTEM AND METHOD FOR REDUCING TRANSFER FUNCTION  
RIPPLE IN A LOGARITHMIC RMS-to-DC CONVERTER

Mail Stop DD  
Commissioner of Patents  
P.O. Box 1450  
Alexandria, VA 22313-1450  
Sir:

INFORMATION DISCLOSURE STATEMENT

In compliance with 37 C.F.R. §§1.56, 1.97, and 1.98, Applicant submits copies of the documents listed on the attached Form PTO-1449.

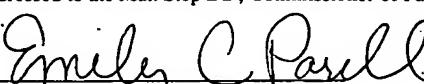
The listed documents were recently cited in a corresponding PCT application, and a copy of the International Search Report is being submitted herewith for purposes of convenience.

The Commissioner is authorized to charge Deposit Order Account No. 19-0079 for any further fee that is required.

Respectfully submitted,

  
Matthew E. Connors  
Registration No. 33,298  
Gauthier & Connors, LLP  
225 Franklin Street, Suite 3300  
Boston, Massachusetts 02110  
Telephone: (617) 426-9180  
Extension: 112

I hereby certify that this paper (along with any paper referred to as being attached or enclosed) is being deposited with the United States Postal Service on the date shown below with sufficient postage as first class mail in an envelope addressed to the Mail Stop DD, Commissioner of Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

  
Emily C. Parcell

07/16/2004  
Date

FORM PTO-1449  
(Rev. 5/92)GAUTHIER & CONNORS LLP  
225 Franklin Street, Boston, MA 02110  
Telephone: (617) 426-9180Analog.7061  
ATTORNEY DOCKET NO.  
APPLICANT: Eamon Nash  
FILING DATE: 02/09/200410/774,905  
SERIAL NO.  
GROUP: 2838  
EXAMINER: Unknown**INFORMATION DISCLOSURE  
STATEMENT BY APPLICANT**

JUL 19 2004

**U.S. PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
AA	3,918,003	11/04/1975	Seidel			10/29/1974
AB	5,724,003	03/03/1998	Jensen et al.			12/29/1995
AC						
AD						
AE						
AF						
AG						
AH						
AI						

**FOREIGN PATENT DOCUMENTS**

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES NO
AJ						
AK						
AL						

**OTHER DOCUMENTS** (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL		
	AM	
	AN	
	AO	

EXAMINER DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.